# UNISYS

DATE:

August 14, 1996

TO:

M. Sampson/311

FROM:

K. Sahu/300.1 KS

SUBJECT:

Radiation Report on: CLR 79

Project:

GOES-K

Control #:

15257

Job#:

EE61984

Project part #:

M39006/22-0631

cc: A. Sharma/311 OFA Library/300.1

PPM-96-008

A radiation evaluation was performed on CLR 79 (Tantalum Electrolyfic Capacitor) to determine the total dose tolerance of these parts. A brief summary of the test results is provided below. For detailed information, refer to Tables I through IV and Figures 1 through 4.

The total dose testing was performed using a Co<sup>60</sup> gamma ray source. During the radiation testing, eight parts were irradiated unbiased and two parts were used as control samples. The total dose radiation levels were 100, 200, 300, 400, 500, 750, and 1000 krads\*. The dose rate was between 1.59 and 4.17 krads/hour (see Table II for radiation schedule). After each radiation exposure, parts were electrically tested according to the test conditions and the specification limits\* listed in Table III.

All parts passed initial electrical measurements.

All irradiated parts passed all electrical tests throughout all irradiation steps up to and including the 1000 krad irradiation level. Less than 1% change in capacitance was observed between the initial and final readings. An average increase of approximately 7% for dissipation factor and 20% for leakage current was seen between the initial and final readings.

Table IV provides the raw data and the mean and standard deviation values for each parameter before irradiation and after each irradiation exposure. Mean values of capacitance, dissipation factor and DC leakage are plotted with range bars in Figures 1, 2, 3 and 4, respectively.

Any further details about this evaluation can be obtained upon request. If you have any questions, please call me at (301) 731-8954.

<sup>\*</sup> The term rads, as used in this document, means rads(SiO<sub>2</sub>). All radiation levels cited are cumulative.

<sup>\*\*</sup> These are manufacturer's pre-irradiation data specification limits. No post-irradiation limits were provided by the manufacturer at the time these tests were performed.

### ADVISORY ON THE USE OF THIS DOCUMENT

The information contained in this document has been developed solely for the purpose of providing general guidance to employees of the Goddard Space Flight Center (GSFC). This document may be distributed outside GSFC only as a courtesy to other government agencies and contractors. Any distribution of this document, or application or use of the information contained herein, is expressly conditional upon, and is subject to, the following understandings and limitations:

- (a) The information was developed for general guidance only and is subject to change at any time;
- (b) The information was developed under unique GSFC laboratory conditions which may differ substantially from outside conditions;
- (c) GSFC does not warrant the accuracy of the information when applied or used under other than unique GSFC laboratory conditions;
- (d) The information should not be construed as a representation of product performance by either GSFC or the manufacturer;
- (e) Neither the United States government nor any person acting on behalf of the United States government assumes any liability resulting from the application or use of the information.

#### C:\REPORTS\295,DOC

### TABLE I. Part Information

Generic Part Number: CLR 79\*

GOES-K Part Number M39006/22-0631

GOES-K Control Number: 15257

Charge Number: EE61984

Manufacturer: Sprague

Lot Date Code (LDC): 8813

Quantity Tested: 10

Serial Number of Control Sample: 1, 2

Serial Numbers of Radiation Samples: 3, 4, 5, 6, 7, 8, 9, 10

Part Function: Tantalum Electrolytic Capacitor

Part Technology: Nonsolid electrolyte

Package Style: Cylindrical 2 leads

Test Equipment: Bench test setup

Engineer: T. Mondy

<sup>\*</sup> No radiation tolerance/hardness was guaranteed by the manufacturer for this part.

#### C\REPORTS\295,DOC

## TABLE II. Radiation Schedule for CLR 79

EVENT	DATE
1) INITIAL ELECTRICAL MEASUREMENTS	06/10/96
2) 100 KRAD IRRADIATION (2.33 KRADS/HOUR)	<b>-</b> 06/11/96
POST-100 KRAD ELECTRICAL MEASUREMENT	06/13/96
3) 200 KRAD IRRADIATION (4.17 KRADS/HOUR)	06/13/96
POST-200 KRAD ELECTRICAL MEASUREMENT	06/14/96
4) 300 KRAD TRRADIATION (1,59 KRADS/HOUR)	· 06/14/96
4) 300 KRAD IRRADIATION (1.59 KRADS/HOUR)POST-300 KRAD ELECTRICAL MEASUREMENT	06/17/96
5) 400 KRAD IRRADIATION (2.33 KRADS/HOUR)	06/17/96
5) 400 KRAD IRRADIATION (2.33 KRADS/HOUR)POST-400 KRAD ELECTRICAL MEASUREMENT	06/19/96
6) 500 KRAD IRRADIATION (2.50 KRADS/HOUR)	06/19/96
POST-500 KRAD ELECTRICAL MEASUREMENT	
7) 750 KRAD IRRADIATION (2.84 KRADS/HOUR)	06/21/96
POST-750 KRAD ELECTRICAL MEASUREMENT	
8) 1000 KRAD IRRADIATION (2.94 KRADS/HOUR)	06/28/96
POST-1000 KRAD ELECTRICAL MEASUREMENT	

#### C:\REPORTS\295.DOC

Table III. Electrical Characteristics of CLR 79

Test Parameter, t	Jnits	Test conditions	Limits					
		<u> </u>	Min	Max				
Capacitance, µF		120 Hz, Bias = 10 VDC	19.8	24.2				
Dissipation Factor, %		120 Hz, Bias = 10 VDC	-	7.5				
Leakage Current, nA	25°C	Bias = 100 VDC	-	1000				
Leakage Current, nA	t25°C	Bias = 100 VDC	-	9000				

TABLE IV: Electrical Measurement Data and Statistical Analysis after Total Dose Testing of CLR 79 /1

	Spen L	im./2				Total Dase Exposure (TDE) (krads)												
Parameter	min	ınaı	SN	Initial @25°C ;	Initial @125°C	100	200	300	400	500	750	1000 @25°C	1000 @125°C					
Capacitance (µF)	19.8	24.2	3	23.30	24.10	23.40	23,30	23.40	23.40	23.40	23.40	23.40	24.L0					
	_		4	23.30	23.90	23,30	23.30	23.30	23.30	23.30	23.30	23.40	23.99					
			5	23.50	24.10	23,40	23.40	23.40	23.40	23.40	23.40	23.50	24.16					
			-6	23.50	24.20	23,50	23.50	23.50	23.50	23.50	23.50	23.60	24.21					
			7	23.50	24.20	23,50	23.50	23.50	23.50	23.50	23.50	23.60	24.24					
			8	23.50	24.10	23.40	23.40	23.40	23.40	23.40	23.40	23.50	24.11					
			9	23.40	24.10	23.40	23.40	23.40	23.40	23.40	23.40	23.50	24.16					
			10	23.20	23.90	23.20	23.20	23.10	23.10	23.20	23.20	23.20	23.96					
				mean sd	mean sd	Mean 3d	Mexin sd	menn sd	்யகை sd	mean sd	mean sd	mean sd	mean sd					
				23.40 0.11	24.08 0.11	23.39 0.09	23,38 0.10	23.38 0.12	2 23.38 0.12	23.39 0.09	23.39 0.09	23.46 0.12	24.12 0.09					

Spec Llin/2									Total Duse Exposure (TDE) (krads)														
Parameter	Brith	hiax	S/N	Initial (	@25°C	Initial	ā,125°C	10	)0	20	ı)	30	0	40	10	50	0	75	C	T000 g	£25°C	(000 @	⊋125°C
Dissipation Factor (%)	-	7.5	3	2.60		1.80		2.70		2.60		2.70		2.70		2.70		2.30		2.70		2.20	
			4 !	3.00		1.90		3 06		3.10		3.60		3.90		3.10		3.20		3.10		2.39	
			5	2.50		1.80	•	2.46		2.50		2.60		2.50		2.60		2.50		2.68		2.28	
			6	2.30		2.10		3.10		3.00		3.20		3.20		3.20		3.20		3.20		2.40	
			7	3.10		1.80		2.70		2.70		2.70		2.70		2.80		2.80		2.90		2.36	
			14	2.70		2.00		3 30		3,30		3.30		3.30		3.40		3.40		3.40		2.41	
			9	3.20		2.00		3.20		3,30		3.40		3,30		3.40		3.30	· · · · · ·	3,30	•	2.36	
			10	2.60		1.80		2.60		2.60	•••	2.60		2.70		2.70		2.60		2.60		2.34	
				mean	sd	теап	14	теап	şd	mean	sd	mean	şd	пьеап	sd	mean	şd	mean	#d	mesm	ad	mean	şđ
				2.75	0.30	1.90	0.11	2.88	0.30	2.89	0.31	2.94	0.31	2.93	0.29	2.99	0.31	2.98	0.32	2.96	0.30	2.34	0.07

	Spec. I	àm.∕2				Total Dase Exposure (TDB) (krads)										
Parameter	min	max	SON	Initial @25℃	Initial @125°C	100	200	300	400	500	750	1000 @25°C	1000@125°C			
DC Leakage (nA)	-	1000 /3	3	132.70	904.70	173.60	155.20	147.00	147.69	130.00	158.20	177.40	[14].0]			
			4	147.29	916.70	180.80	155.60	147.30	139.80	143.70	157.40	178 40	1183.43			
			5	130.81	898.70	170.80	153.00	141.80	£39.80 =	140.70	151.70	171.30	L001.38			
			6	147.54	917.90	180.90	164.80	144.40	£44.20	141.90	164.00	169.70	L160.49			
			7	130.76	825.40	161.50	153.20	144.70	£32.50	136.50	152.60	166.90	L106.72			
			9	124.07	899.40	167.60	156-30	144.70	141.80	146.10	162.70	177.70	[1][1.17			
			9	128.72	856.20	167.30	149.60	146.00	137.00	138.60	156.80	163.70	E0S9.97			
			10	141.97	826.60	168.90	149.20	143,30	132.00	126.90	148.60	168.20	1103.12			
			•	mean sd	mean sd	mean id	mean ad	mean sd	mean sd	mean sd	mean sd	mesa sd	mean sd			
				135.49 8.33	880.70 36.25	171.43 6.32	154.61 4.57	144,90 1.73	139.34 5.06	138.05 6.23	156.50 4.99	171.66 5.21	£108.36 53.85			

#### Notes:

- 1/ The mean and standard deviation values were calculated over the eight parts irradiated in this testing. The control samples remained constant throughout the testing and are not included in this table.
- 2/ These are manufacturer's non-irradiated data sheet specification limits. No post-irradiation limits were provided by the manufacturer at the time the tests were performed.
- 3/ The maximum specification limit for DC leakage at 125°C is 9000 nA.

Radiation-sensitive parameters: None

Figure 1. CLR79 Wet Tantalum Capacitor Capacitance vs. Total Dose Radiation Exposure

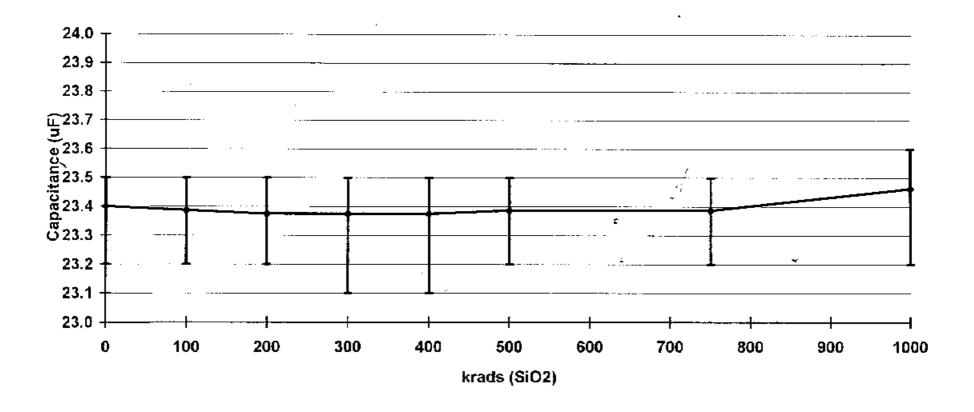


Figure 2. CLR79 Wet Tantalum Capacitor Dissipation Factor vs. Total Dose Radiation Exposure

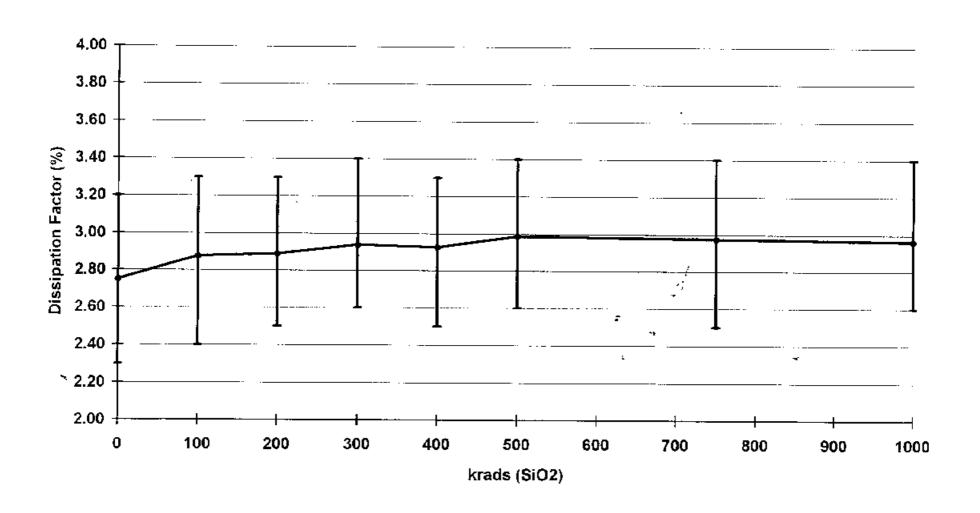


Figure 3. CLR79 Wet Tantalum Capacitor DC Leakage Current (25°C) vs. Total Dose Radiation Exposure

•

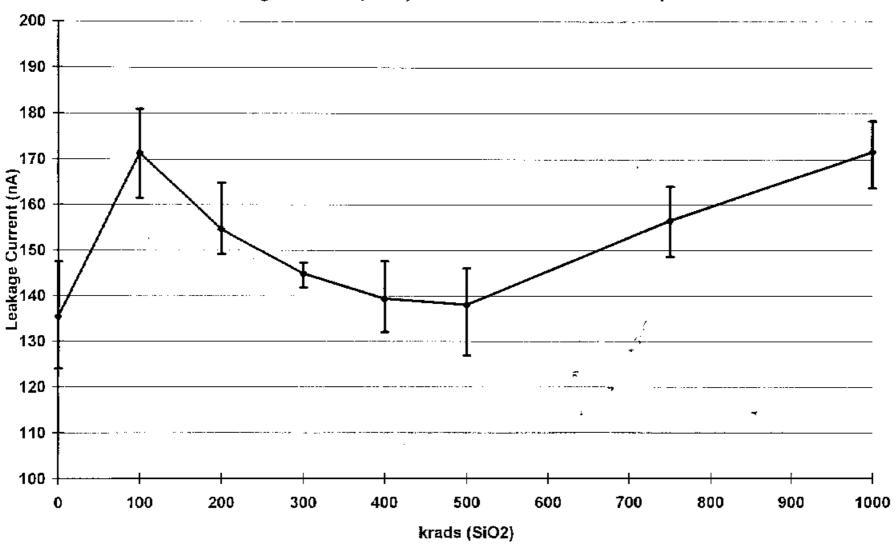


Figure 4. CLR79 Wet Tantalum Capacitor DC Leakage Current (125°C) vs. Total Dose Radiation Exposure

